

Search Notes**Application/Control No.**

10/679,856

Examiner

Pablo N. Tran

Applicant(s)/Patent under Reexamination

BODNAR ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
457	556.1	v 8/12/00	PL
	556.2		
	580.1		
40.3			
575.1			
426.1			
90.1			
90.2			
544-349			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Tard / next	v 8/12/00	PL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner